Search Notes			

Application/Control No.		Applicant(s)/Patent under Reexamination	
	10/720,111	KIM, HYUN-JUNG	
	Examiner	Art Unit	
	John M. Frink	2142	

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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
subclass + text	1/31/2008	JMF
assignee + text	1/31/2008	JMF
inventor	1/31/2008	JMF
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